The Casim ir e ect within scattering theory

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We review the theory of the C asim ir e ect using scattering techniques. A fler years of theoretical e orts, this form alism is now largely m astered so that the accuracy of theory-experiment comparisons is determined by the level of precision and pertinence of the description of experimental conditions. D ue to an imperfect know ledge of the optical properties of real mirrors used in the experiment, the e ect of imperfect relation remains a source of uncertainty in theory-experiment comparisons. For the same reason, the temperature dependence of the C asim ir force between dissipative mirrors remains a matter of debate. We also emphasize that realmirrors do not obey exactly the assumption of specular relation, which is used in nearly all calculations of material and temperature corrections. This di culty may be solved by using a more general scattering form alism accounting for non-specular relation with wavevectors and eld polarizations mixed. This general form alism has a lineady been fruitfully used for evaluating the e ect of roughness on the C asim ir force as well as the lateral C asim ir force appearing between corrugated surfaces. The commonly used proximity force approximity force

I. IN TRODUCTION

A fier its prediction in 1948 [1], the Casim ir force has been observed in a number of historic' experiments which con med its existence and main properties [2{5]. W ith present day technology, a new generation of Casim ir force measurements has started since nearly a decade ago [6{12]. These experiments have reached a good enough accuracy to allow for a comparison between theoretical predictions and experimental observations which is of great interest for various reasons [13{15].

The Casim ir force is the most accessible e ect of vac-1111m uctuations in the macroscopic world. As the existence of vacuum energy raises di culties at the interface between the theories of quantum and gravitational phenom ena, it is worth testing this e ect with the greatest care and highest accuracy [16, 17]. A precise know ledge of the Casim ir force is also a key point in many accurate force m easurem ents for distances ranging from nanom etertom illimeter. These experiments are motivated either by tests of Newtonian gravity at millimetric distances [18{21] or by searches for new weak forces predicted in theoretical uni cation models with nanometric to millimetric ranges [22{27]. Basically, they aim at putting lim its on deviations of experim ental results from present standard theory. As the Casim ir force is the dom inant force between two neutral non-magnetic objects in the range of interest, any new force would appear as a di erence between experimentalmeasurements and theoretical expectations of the C asim ir force. On a technological side, the C asim ir force has been shown to become in portant in the architecture of m icro- and nano-oscillators (MEMS, NEMS) [28, 29]. In this context, it is extremely in portant to account for the conditions of real experiments.

The comparison between theory and experiment should take into account the important di erences between the real experimental conditions and the ideal sit-



FIG.1: O riginal Casim ir con guration of two plane parallel m irrors a distance L apart.

uation considered by Casim ir. Casim ir calculated the force between a pair of perfectly smooth, at and parallelplates in the lim it of zero tem perature and perfect reection (see Fig.1). He found an expression for the force F_{Cas} and the corresponding energy E_{Cas} which only depend on the distance L, the area A and two fundam ental constants, the speed of light c and P lanck constant ~

$$F_{Cas} = \frac{-c^{2}A}{240L^{4}} = \frac{dE_{Cas}}{dL}$$
$$E_{Cas} = -\frac{-c^{2}A}{720L^{3}}$$
(1)

Each transverse dimension of the plates has been supposed to be much larger than L.C onventions of sign have been chosen so that F_{Cas} is positive while E_{Cas} is negative. They correspond to an attractive force (0:1 N for $A = 1 \text{ cm}^2$ and L = 1 m) and a binding energy.

The fact that the C asim ir force (1) only depends on fundamental constants and geometrical features is remarkable. In particular it is independent of the ne structure constant which appears in the expression of the atom ic Van der W aals forces. This universality property is related to the assumption of perfect re ection used by C asim ir in his derivation. Perfect m irrors correspond to a saturated response to the elds since they re ect 100% of the incom ing light. This explains why the C asim ir e ect, though it has its m icroscopic origin in the interaction of electrons with electrom agnetic elds, does not depend on the ne structure constant.

However, no realm into can be considered as a perfect re ector at all eld frequencies. In particular, the most precise experiments are performed with metallic minors which show perfect re ection only at frequencies smaller than a characteristic plasm a frequency $!_P$ which depends on the properties of conduction electrons in the metal. Hence the C asim ir force between metalplates can t the idealC asim ir formula (1) only at distances L much larger than the plasm a wavelength

$$P_{\rm P} = \frac{2 c}{! P_{\rm P}}$$
(2)

For m etals used in the recent experiments, this wavelength lies in the 0:1 m range (107nm for A land 137nm for C u and A u). At distances smaller than or of the order of the plasm a wavelength, the nite conductivity of the m etal has a signi cant e ect on the force. The idea has been known since a long time [30{32] but a precise quantitative investigation of the e ect of imperfect reection has been system atically developed only recently [33{36]. As the e ect of imperfect re ection is large in the most accurate experiments, a precise know ledge of its frequency dependence is essential for obtaining an accurate theoretical prediction of the C asim ir force.

This is also true for other corrections to the ideal Casim ir formula associated with the experimental conguration. For experim ents at room tem perature, the effect of therm al eld uctuations, superim posed to that of vacuum, a ects the Casim ir force at distances larger than a few microns. A gain the idea has been known for a long time [37, 38] but a quantitative evaluation taking into account the correlation of this e ect with that of im perfect re ection has been mastered only recently [39, 40]. A number of publications have given rise to contradictory estimations of the Casim ir force between dissipative m irrors at non zero tem perature [41{45]. M any attem pts have been made to elucidate the problem by taking into account the low -frequency character of the force between m etallic lm s [46], the spatial dispersion on electrom agnetic surface m odes [47] or the transverse m om entum dependance of surface in pedances [48{50]. Experim entally the e ect oftem perature of the C asim ir force has not yet be conclusively measured [51]. For a recent analysis of this issue see reference [52].

M ost experiments are performed between a plane and a sphere with the force estimation involving a geometry correction. U sually the C asim in force in the plane-sphere (PS) geometry is calculated using the Proximity Force Approximation (PFA). This approximation amounts to the addition of force or energy contributions corresponding to di erent local inter-plate distances, assuming these contributions to be independent. But the Casim ir force and energy are not additive, so that the PFA cannot be exact, although it is often in properly called a theorem.

In the present review, we consider both the original C asim ir geom etry with perfectly plane and parallelm irrors and the plane-sphere geom etry when com paring to experiments. The PFA is expected to be valid in the plane-sphere geom etry, when the sphere radius R ism uch larger than the separation L [53{55], which is the case for all present day experiments, and it will thus be used to connect the two geom etries. In this case, the force F_{PS} between a sphere of radius R and a plane at a distance of closest approach L is given in term s of the energy E_{PP} for the plane-plane cavity as follow s

$$F_{PS} = 2 R \frac{E_{PP}}{A} ; L R \qquad (3)$$

Interesting attempts to go beyond this approximation concerning the plane-sphere geometry have been made recently [56, 57], in the more general context of the connection between geometry and the Casim ire ect [58{60].

Another important correction to the Casim ir force is com ing from surface roughness, which is intrinsic to any real mirror, with amplitude and spectrum varying depending on the surface preparation techniques. The departure from atness of the metallic plates may also be designed, in particular under the form of sinusoidal corrugation of the plates which produce a measurable lateral component of the Casim ir force [61]. For a long time, these roughness or corrugation corrections to the Casim ir force have been calculated with methods valid only in limiting cases [62{67] or by using PFA [68{70]. Once again, it is only recently that emphasis has been put on the necessity of a more generalm ethod for evaluating the e ect of roughness outside the region of validity of PFA with imperfect m irrors at arbitrary distances from each other [71]. W hile the condition L R is su cient for applying the PFA in the plane-sphere geom etry, m ore stringent conditions are needed for PFA to hold for rough or corrugated surfaces. The surfaces should indeed be nearly plane when looked at on a scale comparable with the separation L, and this condition is not always satis ed in experiments. W hen PFA is no longer valid, the e ect of roughness or corrugation can be evaluated by using the scattering theory extended to the case of non-specular re ection.

We review the Casim ir e ect within scattering theory and the theory of quantum optical networks. The main idea of this derivation is that the Casim ir force has its origin in a di erence of the radiation pressure of vacuum elds between the two m irrors and in the outer free eld vacuum. This vacuum radiation pressure can be written as an integral over all modes, each mode being associated with re ection amplitudes on the two m irrors. We rst present form ulas written for specular re ection which are valid for lossless[72] as well as lossy m irrors [73]. We discuss the in uence of the m irrors re ection coe cients at



FIG.2: Schematic view of a Fabry-Perot cavity of length L.

zero and non-zero tem perature. We then extend the approach to the case of non-specular relection which mixes the eld polarizations and transverse wave-vectors. Finally we apply the latter approach to the calculation of the roughness correction to the Casim ir force between m etallic mirrors [74, 75] and of the lateral component of the Casim ir force between corrugated plates [76].

II. SPECULAR SCATTERING

Let us rst consider the original C asim ir geom etry with perfectly plane and parallelm irrors aligned along the directions x and y. The two m irrors thus form a Fabry-Perot cavity of length L as shown in Fig 2. We analyze the cavity as a composed optical network, and calculate the uctuations of the intracavity elds propagating along the positive and negative z-axis, $E_{\rm C}$ and $E_{\rm C}$, in terms of the uctuations of the incom ing free-space elds $E_{\rm L}^{\rm in}$ and $E_{\rm R}^{\rm in}$ (the outgoing elds $E_{\rm L}^{\rm out}$ and $E_{\rm R}^{\rm out}$ are also shown).

The eld modes are conveniently characterized by their frequency !, transverse wavevector k with components k_x ; k_y in the plane of the m irrors and polarization p. As the con guration of Fig 2 obeys a sym m etry with respect to time translation as well as transverse space translations (along directions x and y), the frequency !, transverse vector k $(k_x; k_v)$ and polarization p = TE; TMare preserved throughout the whole scattering processes on a mirror or a cavity. The scattering couples only the free vacuum modes which have the same values for the preserved quantum num bers and dier by the sign of the longitudinal com ponent k_z of the wavevector. We denote by $(r_k^p [!])_j$ the relection amplitude of the mirror j = 1;2as seen from the inner side of the cavity. This scattering am plitude obeys general properties of causality, unitarity and high frequency transparency. The additional uctuations accompanying losses inside the mirrors are deduced from the optical theorem applied to the scattering process which couples the modes of interest and the noise modes [77, 78].

The loop functions which characterize the optical response of the cavity to an input eld play an important role in the following

$$f_{k}^{p}[!] = \frac{\sum_{k=1}^{p}[!]}{1 - \sum_{k=1}^{p}[!]}$$

$$\sum_{k=1}^{p}[!] = (r_{k}^{p}[!])_{1}(r_{k}^{p}[!])_{2}e^{2ik_{2}L}$$
(4)

 $_{k}^{p}$ and f_{k}^{p} are respectively the open-bop and closed-bop functions corresponding to one round trip in the cavity. The system formed by the m irrors and elds is stable so that f_{k}^{p} is an analytic function of frequency !. A nalyticity is de ned with the following physical conditions in the complex plane

! i ; < >0 (5)
i [!] ; [!]
$$k^2 \frac{!^2}{c^2}$$
 ; < [!] > 0

The quantum numbers p and k remain spectator throughout the discussion of analyticity. The sum on transverse wavevectors may be represented as a sum over the eigenvectors $k_x = 2$ $q_x = L_x$; $k_y = 2$ $q_y = L_y$ associated with virtual quantization boxes along x; y or, at the continuum limit L_x ; L_y ! 1 with $A = L_x L_y$, as an integral

 k_z

We then introduce the Airy function de ned in classical optics as the ratio of energy inside the cavity to energy outside the cavity for a given mode

$$g_{k}^{p}[!] = 1 + ff_{k}^{p}[!] + c c g = \frac{1 \quad j_{k}^{p}[!]j_{1}^{2}}{j_{k}^{p} \quad [!]j_{1}^{2}}$$
(7)

 f_k^p , g_k^p depend only on the rejection amplitudes of mirrors as they are seen from the inner side. W ith these de nitions we write the Casim ir force

$$F = \sum_{p=k}^{X} \sum_{k=0}^{X} \frac{d!}{2} \text{ fi } [!] f_{k}^{p} [!] + ccg (8)$$

or, equivalently, the Casim ir energy

$$E = \sum_{p=k}^{X} \sum_{k=0}^{X} \frac{d!}{2} \frac{1}{2i} \ln \frac{1}{1} \frac{p}{k} \frac{[!]}{p} \qquad (9)$$

Equations (8,9) contain the contribution of ordinary modes freely propagating outside and inside the cavity with $! > c_k j$ and k_z real. This contribution thus merely reacts the intuitive picture of a radiation pressure of uctuations on the mirrors of the cavity [72] with the factor g_k^p 1 representing a di erence between inner and outer sides. Equations (8,9) also include the contribution of evanescent waves with $! < c_k j$ and k_z in aginary.

Those waves propagate inside the m irrors with an incidence angle larger than the limit angle and they also exert a radiation pressure on the m irrors, due to the frustrated re ection phenom enon [73]. Their properties are conveniently described through an analytical continuation of those of ordinary waves, using the well de ned analytic behavior of and f_{ν}^{p} .

U sing analyticity properties, we now transform (8) into an integral over in aginary frequencies by applying the C auchy theorem on the contour enclosing the quadrant <!>0;=!>0.W e use high frequency transparency to neglect the contribution of large frequencies. This leads to the following expression for the C asim ir force

$$F = \sim \frac{X X^{2} 1}{p k^{0}} \frac{d}{2} f [i] f_{k}^{p} [i] + c \pi g \qquad (10)$$

which is now written as an integral over complex frequencies ! = i . In the same way we obtain the Casim ir energy as a function of im aginary frequencies

$$E = \frac{-A}{2} X \frac{X}{4} \frac{d^{2}k}{4^{2}} d \ln [l \frac{p}{k}[i]]$$
(11)

Causality and passivity conditions assure that the integrand $\ln \left[l \right]_{k}^{p} \left[i \right]$ is analytical in the upper half space of the complex plane < > 0. It is thus clear that both expressions for force and energy are equivalent.

A. Finite conductivity correction

Let us now review the correction to the C asim ir force coming from the nite conductivity of any material. This correction is given by relations (8) or, equivalently, (10), as soon as the rejection amplitudes are known. These amplitudes are commonly deduced from models of mirrors, in particular bulk mirrors, slabs or layered mirrors, the optical response of metallic matter being described by some permittivity function. This function may be either a simple description of conduction electrons in terms s of a plasm a or D rude model or a more elaborate representation based upon tabulated optical data. At the end of the section, we will discuss the uncertainty in the theoretical evaluation of the C asim ir force coming from the lack of know ledge of the species of a given mirror as was illustrated in [34].

A ssum ing that the metal plates have a large optical thickness, the rejection ∞ cients correspond to the ones of a simple vacuum bulk interface [80]

$$\mathbf{r}^{\mathrm{TE}} = \frac{p}{\frac{2 (\mathbf{"}(\mathbf{i}) + \mathbf{i}) + \hat{c}^{2}}{2} \mathbf{c}}}{\frac{p}{\frac{2 (\mathbf{"}(\mathbf{i}) + \mathbf{i}) + \hat{c}^{2}}{2} + \mathbf{c}}}$$
$$\mathbf{r}^{\mathrm{TM}} = \frac{p}{\frac{2 (\mathbf{"}(\mathbf{i}) + \mathbf{i}) + \hat{c}^{2}}{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}}}{\mathbf{i} \mathbf{i} \mathbf{i} \mathbf{i} + \hat{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}^{2} \mathbf{c}}$$
(12)

 r^p stands for r^p (i ; i) and " (i) is the dielectric function of the m etalevaluated for in aginary frequencies; the index k has been dropped.

Taken together, the relations (10,12) reproduce the Lifshitz expression for the C asim ir force [30]. Note that the expression was not written in thism anner by Lifshitz. To our present know ledge, K ats [81] was the rst to stress that Lifshitz expression could be written in terms of the re ection am plitudes (12). We then have to emphasize that (10) is much more general than Lifshitz expression since it still holds with m irrors characterized by re ection am plitudes di ering from (12). As an illustration, we may consider metallic slabs having a nite thickness.

For a given polarization, we denote by r_{si} the rejection coecient (12) corresponding to a single vacuum /m etal interface and we write the rejection amplitude r for the slab of nite thickness through a Fabry-Perot form ula

$$r = r_{si} \frac{1 e^{2}}{1 r_{si}^{2} e^{2}}$$
$$= \frac{D}{c} \frac{p}{c} \frac{p}{2} ("(i) - 1) + c^{2}$$
(13)

This expression has been written directly for in aginary frequencies. The parameter represents the optical length in the metallic slab and D the physical thickness. The single interface expression (12) is recovered in the lim it of a large optical thickness 1. W ith the plasm a model, this condition just means that the thickness D is larger than the plasm a wavelength $_{\rm P}$.

In order to discuss experiments, it may also be worth to write the rejection coeccients for multilayer mirrors. For example one may consider two-layer mirrors with a layer of thickness D of a metal A deposited on a large slab of metal B in the limit of large thickness as shown in Figure 3. The rejection formulas are then obtained as



FIG. 3: Composition of networks : two networks labeled A and B are piled up to build up a network AB.

in [82] but accounting for oblique incidence

$$r_{AB} = r_A + \frac{t_A^2 r_B}{1 r_A r_B}$$
; $t_{AB} = \frac{t_A t_B}{1 r_A r_B}$ (14)

It reproduces the known results for the simple multilayer system s which have already been studied [13]. The com – bination of (13) and (14) allows to calculate most of the experimental situations precisely.

In order to assess quantitatively the e ect of nite conductivity, we may in a rst approach use the plasma model for the metallic dielectric function, with $!_P$ the plasm a frequency,

"(!) = 1
$$\frac{!\frac{2}{p}}{!^2}$$
; "(i) = 1 + $\frac{!\frac{2}{p}}{2}$ (15)



FIG.4: Reduction of the Casim ir force compared to the force between perfect m irrors, when the nite conductivity is described by a plasm a model (solid line) or a D rude model (dashed line) with a ratio $\frac{1}{12}$ equal to 4 10³. The di erence due to the relaxation parameter has only a small e ect on the calculation of the C asim ir force. The dotted-dashed line corresponds to the short distance asymptotic behavior (17).

It is convenient to present the change in the C asim ir force in terms of a factor $_{\rm F}$ which measures the reduction of the force with respect to the case of perfect mirrors

$$F = F_F F_C$$
(16)

U sing expressions (12,15) it is possible to obtain the reduction factor de ned for the Casim ir force through numerical integrations.

The result is plotted as the solid line on gure 4, as a function of the dimensionless parameter $\frac{L}{p}$, that is the ratio between the distance L and the plasm a wavelength p. As expected the Casim ir form ula is reproduced at large distances ($_{\rm F}$! 1 when L $_{\rm P}$). At distances smaller than $_{\rm P}$ in contrast, a signi cant reduction is obtained with the asymptotic law of variation read as [84, 85]

L _P ! _F =
$$\frac{L}{P}$$
 / 1:193 (17)

This can be understood as the result of the Coulom b interaction of surface plasm ons at the two vacuum /m etal interfaces [83, 84]. The generalization of this idea at arbitrary distances is more subtle since it involves a full electrom agnetic treatm ent of the plasm on as well as ordinary photon m odes [86].

The plasm a model cannot provide a fully satisfactory description of the optical response of metals, in particular because it does not account for any dissipative mechanism. A more realistic representation is the D rude model

[87]

"(!) = 1
$$\frac{!_{p}^{2}}{!(!+i)}$$

"(i) = 1 + $\frac{!_{p}^{2}}{(+)}$ (18)

This model describes not only the plasma response of conduction electrons with $!_P$ still interpreted as the plasma frequency but also their relaxation, being the inverse of the electronic relaxation time.

The relaxation parameter is much smaller than the plasm a frequency. For A l, Au, Cu in particular, the ratio =!_p is of the order of 4 10³. Hence relaxation a ects the dielectric constant in a signi cant manner only at frequencies where the latter is much larger than unity. In this region, the metallic m irrors behave as a nearly perfect re ectors so that, nally, the relaxation does not have a large in uence on the C asim ir e ect at zero tem – perature. This qualitative discussion is con m ed by the result of num erical integration reported as the dashed line on gure 4. W ith the typical value already given for =!_p, the variation of _F remains everywhere smaller than 2%.

For metals like Al, Au, Cu, the dielectric constant departs from the D rude m odel when interband transitions are reached, that is when the photon energy reaches a few eV. Hence, a more precise description of the dielectric constant should be used for evaluating the Casim ir force in the sub-m range. This description relies on one hand on the causality relations obeyed by the dielectric response function and on another hand on known optical data. The reader is referred to [34] for a detailed analysis, but we recall here the main argum ent and som e in portant details. Let us st recall that frequencies are m easured either in eV or in rad/s, using the equivalence 1 eV = 1.519 $10^{15} \text{ rad/s. A n erroneous conversion fac$ tor 1 eV = 1.537 $10^{15} \text{ rad/swasused in [34], which led}$ to a dierence in "(i) of less than 1% over the relevant distance range. In the end of the calculation, this was corresponding to a negligible error in the Casim ir force and energy [88].

The values of the complex index of refraction for different m etals, m easured through di erent optical techniques, are tabulated as a function of frequency in severalhandbooks [89{91]. Optical data m ay vary from one reference to another, not only because of experim ental uncertainties but also because of the dispersion of m aterial properties of the analyzed sam ples. M oreover, the available data do not cover a broad enough frequency range so that they have to be extrapolated. These problem s m ay cause variations of the results obtained for the dielectric function " (i) and, therefore, for the C asim in force.

Figure 5 shows two di erent plots of "(i) for Cu as a function of in aginary frequency . The solid line corresponds to the rst data set with data points taken from [89, 90] and extrapolation at low frequency with a D rude





FIG.5: D ielectric function of C u versus in aginary frequency. The solid line corresponds to the rst set (optical data given by [89, 90], low frequencies extrapolated by a D rude m odel with $!_P = 8:97$ eV and = 29:5 m eV), the dashed line to the second set (optical data given by [91], low frequencies extrapolated by a D rude m odel with $!_P = 7:5$ eV and = 130 m e V).

FIG.6: Reduction factor $_{\rm F}$ for the C asim in force between two C u plates as a function of the plate separation L. The solid line corresponds to the rst set (optical data given by [89], low frequencies extrapolated by a D rude m odel with $!_{\rm P}$ = 8:97 eV and = 29.5 m eV), the dashed line to the second set (optical data given by [91], low frequencies extrapolated by a D rude m odel with $!_{\rm P}$ = 7:5 eV and = 130 m eV).

m odel with parameters $!_{P} = 8:97 \text{ eV}$ and = 29.5 m eVin reasonable agreement with existing knowledge from solid state physics. However, as explained in [34], the optical data available for Cu do not permit an unam – biguous estimation of the two parameters $!_{P}$ and separately. O ther couples of values can be chosen which are also consistent with optical data. To make this point explicit, we have drawn a second plot on gure 5 (dashed line) with data taken from [91] and the low frequency interpolation given by a D rudem odel with $!_{P} = 7.5 \text{ eV}$ and

= 130 m eV. These values lead to a dielectric function "(i) smaller than in the rst data set over the whole frequency range, but especially at low frequencies. An estimation of the uncertainties associated with this im - perfect know ledge of optical data can be drawn from the computation of the C asim ir force in these two cases.

Figure 6 shows the reduction factor $_{\rm F}$ for the C asim in force between two Cu plates as a function of the plate separation L for the two sets of optical data. The two corresponding curves have similar dependance on the plate separation but the absolute values are shifted from one curve to the other. At a separation of 100 nm the difference can be as large as 5%. As the plasm a frequency is basically the frequency above which the m informs re-ectivity diminishes considerably, the D nude parameters of the rst set (! $_{\rm P}$ = 8:97 eV and = 29.5 m eV) give a larger C asim in force than the second set, where the plasm a frequency is lower (! $_{\rm P}$ = 7.5 eV and = 130 m eV). A detailed analysis of this uncertainty has been recently reported [92].

Let us emphasize that the problem here is neither due to a lack of precision of the calculations nor to inaccuracies in experiments. The problem is that calculations and experiments may consider physical systems with different optical properties. Material properties of mirrors indeed vary considerably as a function of external parameters and preparation procedure [92]. This diculty could be solved by measuring the rejection amplitudes of the mirrors used in the experiment and then inserting these informations in the formula giving the predicted Casimir force. In order to suppress the uncertainty associated with the extrapolation procedure, it would be necessary to measure the rejection amplitudes down to frequencies of the order of 1 meV, if the aim is to calculate the Casimir force in the distance range from 100 nm to a few m.

B. Tem perature correction

The C asim ir force between dissipative m etallic m irrors at non zero temperature has given rise to contradictory claim swhich have raised doubts about the theoretical expression of the force. In order to contribute to the resolution of this di culty, we now review brie y the derivation of the force from basic principles of the quantum theory of lossy optical cavities at non zero temperature. W e obtain an expression which is valid for arbitrary m irrors, including dissipative ones, characterized by frequency dependent re ection am plitudes. This expressions coincides with the usualL ifshitz expression when the plasm a m odel is used to describe the m irrors m aterial properties, but it di ers when the D rude m odel is applied. The di erence can be traced back to the validity of P oisson sum m ation form ula [40].

To discuss the e ect of nite temperature we use a

theorem which gives the commutators of the intracavity elds as the product of those well known for elds outside the cavity by the Airy function. This theorem was dem onstrated with an increasing range of validity in [72], [79] and [73]. It is true regardless of whether the m irrors are lossy or not. Since it does not depend on the state of the eld, it can be used for therm alas well as vacuum uctuations. A ssum ing therm al equilibrium, the theorem leads to the expression of the eld anticom mutators, i.e. the eld uctuations. Note that therm al equilibrium has to be assumed for the whole system, which means that input elds as well as uctuations associated with electrons, phonons and any loss mechanism inside the m irrors correspond to the sam e tem perature T, w hatever their m icroscopic origin may be. If parts of the system correspond to di erent tem peratures, com pletely di erent results are obtained [94, 95].

The anticom mutators of intracavity elds are given by those known for elds outside the cavity multiplied by the Airy function. Hence, the expression written in [73] for a null temperature is only modied through the appearance of a therm al factor in the integrand

$$F = \sum_{\substack{p,k=0 \\ p,k=0}}^{X} \frac{2}{2} \operatorname{fi}_{k} [!] f_{k}^{p} [!] c [!] + c c g$$

$$c [!] \operatorname{coth} \frac{!}{!_{T}} ; !_{T} \frac{2 k_{B} T}{\sim} (19)$$

U sing as before analyticity properties, we transform (19) into an integral over imaginary frequencies giving the following expression for the Casim ir force

$$F = \sim \frac{X + \frac{Z}{2}}{\frac{D}{D^{2}}} \frac{d}{2} f [i +]_{R}^{D} [i +]c[i +] + cxxx(20)$$

It is now written as an integral over complex frequencies ! = i + close to the imaginary axis, with the small positive real number $! 0^{+}$ maintaining the M atsubara poles $!_{m} = im !_{T}$ of c[!] outside the contour used to apply the C auchy theorem . Up to this point, the present derivation is similar to Lifshitz' demonstration [30] while being valid for arbitrary rejection amplitudes. The next steps in Lifshitz' derivation, scrutinized in [40], may raise di culties for dissipativem irrors. Let us brie y recall the main arguments of [40].

We may rst write a series expansion of the Casimir force (19) based upon the expansion of the function $\operatorname{coth} \frac{!}{!_{\mathrm{T}}}$ into a series of exponentials exp $\frac{2n}{!_{\mathrm{T}}}$ (see also [39]). This expansion obeys the mathematical criterion of uniform convergence so that, when it is inserted in (19), the order of the sum mation over n and integration over may be exchanged. It follows that the force (19)

m ay also be read as

$$F = -\frac{x^{2} X X^{2} X^{0}}{z_{1}^{p}} \exp \left(\frac{2n}{t_{T}} \right)$$

$$= \frac{z_{1}^{p}}{z_{1}^{p}} \exp \left(\frac{2n}{t_{T}} \right)$$

W e have introduced the comm on summation convention

$$X^{0}$$
 '(n) $\frac{1}{2}$ '(0) + X^{1} '(n) (22)

The function $\frac{p}{k}$ is well de ned almost everywhere, the only possible exception being the point = 0 where the lim it ! 0⁺ m ay be ill de ned for m inrors described by dissipative optical models [44]. Since this is a domain of null measure, the cosine Fourier transform $\frac{e^p}{k}$ of $\frac{p}{k}$ is well de ned everywhere and the expression (21) of the Casim ir force is valid for arbitrary m inrors, including dissipative ones. Note that the term n = 0 in (21) corresponds exactly to the contribution of vacuum uctuations, or to the zero tem perature lim it, while the term s n 1 give the corrections associated with therm al elds.

We come back to the derivation of the Lifshitz form ula [30], often used as the standard expression of the C asim ir force. This form ula is directly related to the decomposition of the coth function into elementary fractions corresponding to the M atsubara poles $_{\rm m}$ = im !_T. If we assume furtherm ore that the function $_{\rm k}^{\rm p}$ is a su ciently smooth test function, in the sense de ned by the theory of distributions, we deduce that the expression (20) can also be read

$$F_{L if} = \frac{ \sim !_{T}}{p} X X X^{0}$$

$$p_{k m} p_{k m} p_{k} p_{$$

This is the generalization of the Lifshitz' form ula [30] to the case of arbitrary rejection amplitudes. It is a discrete sum over M atsubara poles with the primed summation symbol having the denition (22). This form ula is known to lead to the correct result in the case of dielectric m irrors (for which it was derived in [30]), for perfect m irrors [37, 38] and also for m etallic m irrors described by the lossless plasm a model [39].

However its applicability to arbitrary m irrors remains a matter of controversy [44]. The point is that the derivation of the Lifshitz' form ula (23) requires that the function $_{k}^{p}$ be a su ciently smooth test function, in the sense dened by the theory of distributions. Whether or not this is the case at = 0 for $_{k}^{p}$ calculated from dissipative optical models constitutes the central question of the controversy on the value of the term p=TE, m = 0in Lifshitz' sum [41[45]. Let us repeat that (21) is still a mathematically valid expression of the Casim ir force even when $_{k}^{p}$ is ill dened for in a domain of null measure. The question of validity of Lifshitz' formula (23) m ay also be phrased in terms of applicability of the Poisson summation formula [93]. This applicability depends on a smoothness condition which is met for dielectric m irrors, for perfect m irrors and form irrors described by the plasm a model and this explains why Lifshitz' formula (23) may be used as well as (21) in these cases [40].

In order to solve this controversy, it is crucial to in prove our know ledge of the re ection am plitudes at low frequencies. As already discussed, the best manner to do that is to measure these am plitudes on the mirrors used in the experiment at frequencies as low as possible. A lthough the theoretical question of a good modeling of mirrors at low frequencies is certainly of interest and needs to be answered, the crucial point for a reliable theory-experiment com parison is the necessity of assessing the real behavior of the mirrors used in the experiments.

III. NON SPECULAR SCATTERING

W e will now present a more general form alism to calculate the C asim ir force and energy which takes into account non-specular re ection by the plates. N on-specular re ection is of course the generic re ection process on any m irror while specular re ection is an idealization.

In order to introduce the more general formula, let us rst rewrite expression (11) of the Casim ir energy between two at plates as a sum overmodes labeled by the and m k;p

$$E_{sp} = \sim \int_{0}^{2^{h}} \frac{d}{2} \operatorname{Tr} _{k}^{p} [i]$$

$$\int_{0}^{p} [i] = \ln 1 \quad \operatorname{rr}_{2} e^{2 L} \qquad (24)$$

This can be interpreted as the energy stored inside the cavity during the scattering process. It is expressed in terms of the phase shifts ${}^{p}_{k}$ [i] acquired by the eld modes upon scattering on the cavity. These phase shifts are deduced from the S-matrix of the cavity [72] in such a manner that the C asim ir energy is simply equal to the logarithm of the determinant of the S matrix. U sing the techniques of quantum eld theory [59], this can also be written as the trace of matrix, here diagonal, de ned on these modes

$$E_{sp} = \sim \frac{d}{2} \frac{d}{2} m j \ln (1 n_{r} r_{2} e^{2 iL}) jn i$$
 (25)

Here, r_1 and r_2 are diagonal matrices which contain as their diagonal elements the specular relation amplitudes, as they are seen from elds inside the cavity,

while is a matrix diagonal over the same modes

hm j jn⁰i
$$p \frac{1}{k_m^2 + 2} m_{mm^0}$$
 (27)

It is now easy to write down a more general form ula of the Casim ir energy for the case of stationary but nonspecular scattering

$$E_{nsp} = \sim \int_{0}^{Z_{1}} \frac{d}{2} Tr \ln 1 \quad R_{1}e^{-L} R_{2}e^{-L}$$
 (28)

The two matrices R_1 and R_2 are no longer diagonal on plane waves since they describe non specular relation on the two mirrors. The propagation factors remain diagonalon plane waves. Note that the matrices appearing in (28) no longer commute with each other. As a consequence, the two propagation matrices in (28) can be moved through circular permutations in the product but not adjoined to each other.

Form ula (28) has already been used to evaluate the e ect of roughness [74, 75] or corrugation [76] of the m irrors on the C asim ir force. To this aim, it was expanded at second order in the proles of them irrors, with the optical response of the bulk m etals described by the plasm a m odel. The non specular rejection amplitudes were then deduced from techniques developed for treating rough plates [96, 97]. The condition of validity of this expansion is that the roughness or corrugation amplitude is the smallest of length scales involved in the problem. In this regime, it was possible to investigate various domains for the roughness or corrugation outside as well as inside the range of validity of the P roxim ity Force Approximation.

We may again emphasize at this point that the formula (28) has a wider range of validity than used in those applications. It can in principle describe m irrors with nanostructured surfaces corresponding to large am – plitudes which cannot be treated as a small perturbation. It can as well deal with m ore complicated optical responses which are described neither by a plasm a nor by a D rude m odel. As was extensively discussed above for the case of specular re ection, the form ula (28) remains valid for arbitrary m irrors, the only problem being to obtain the precise form of the re ection matrices to be inserted into it.

A. In uence of surface roughness

Let us now recall how the non-specular scattering formula (28) can be used to calculate the e ect of roughness on the C asim ir force. Taking this e ect into account simultaneously with that of nite conductivity is essential, because both of them are in portant at short distances. In order to analyze the roughness e ect between two m etallic plates, we will describe the optical properties of the m irrors by the plasm a model. The values for



FIG.7: M agni ed detail of the internal surface of m irror M 1.

the plasma wavelength, the mirror separation and the roughness correlation length will be arbitrary with respect to each other, the roughness am plitude remaining the smallest length scale for perturbation theory to hold. W e will review some simple analytical expressions for several limiting cases, as well as numerical results allowing one for a reliable calculation of the roughness correction in real experiments [74, 75].

In a plane-plane geom etry, the surface pro les are dened by the functions $h_i(x;y)$ (i = 1;2) giving the local heights with respect to the m ean separation L along the z direction as shown in Fig.7. These functions are dened so that they have zero averages. We consider the case of stochastic roughness characterized by spectra

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$$d^{2}re^{ik} h_{i}(r) h_{j}(0)i; i=1;2$$
 (29)

W e suppose the surface A of the plates to contain m any correlation areas, which allows us to take ensemble or surface averages interchangeably. The two plates are considered to be m ade of the sam e m etal and the crossed correlation between their proles is neglected ($_{12}$ (k) = 0).

W e obtain the follow ing variation of the C asim ir energy $E_{\rm PP}$ up to second order in the perturbations $h_{\rm i}$ [71]

$$E_{PP} = \frac{Z}{4^{2}k} G_{r}(k) (k)$$
(30)
(k) = 11 (k) + 22 (k)

W ith our assumptions, the spectrum (k) fully characterizes the roughness of the two plates. The correlation length 'c is de ned as the inverse of its width. The response function $G_r(k)$ then describes the spectral sensitivity to roughness of the C asim ir e ect. Sym m etry requires that it only depends on $k = \frac{1}{2}k$ j. The dependance of G_r on k re ects that not only the roughness am plitude but also its spectrum plays a role in di raction on rough surfaces [96, 97]. The form ula (30) has been obtained for the energy in the plane-plane con guration but it also determ ines the force correction F_{PS} in the plane-sphere con guration since the PFA is still used for describing the weak curvature of the sphere (see below).

We now focus our attention on the validity of PFA for treating the e ect of roughness and notice that this validity only holds at the lim it of sm ooth surface pro les k ! 0. In fact, the following identity is obeyed by our result [74], for arbitrary values of L and P,

$$G_{r}(k! 0) = \frac{E_{PP}^{(0)}(L)}{2}$$
 (31)

where the derivative is taken with respect to the plate separation L. If we now suppose that the roughness spectrum (k) is included inside the PFA sector where $G_r(k)$ ' $G_r(0)$, G_r m ay be replaced by $G_r(0)$ and factored out of the integral (30) thus leading to the PFA expression [71]

$$E_{PP} = \frac{E_{PP}^{(L)}(L)}{2}a^{2}$$
(32)
$$a^{2} = \frac{d^{2}k}{4^{2}}(k) \quad h_{1}^{2} + h_{2}^{2}i$$

In this PFA limit, the correction depends only on the variance a^2 of the roughness proles, that is also the integral of the roughness spectrum .

In the general case in contrast, the sensitivity to roughness depends on the wavevector k. This key point is emphasized by introducing a new function $_{\rm r}(k)$ which measures the deviation from the PFA [71]

$$_{r}(k) = \frac{G_{r}(k)}{G_{r}(0)}$$
: (33)

This function is plotted on F ig.8 for several values of L. As for all num erical examples considered below, we take $_{\rm P}$ = 137nm which corresponds to gold covered plates.

The ratio $_{r}(k)$ is alm ost everywhere larger than unity, which means that the PFA system atically underestimates the roughness correction. The inlet shows $_{r}(k)$ for small values of k where the PFA is a good approximation. To give a number illustrating the deviation from the PFA, we nd $_{r}$ ' 1:6 for L = 200nm and k = 0.02nm ¹, which means that the exact correction is 60% larger than the PFA result for this intermediate separation and a typical roughness wavelength 2 =k' 300nm.

Fig.8 indicates that $_{r}(k)$ grows linearly for large values of k. This is a general prediction of our full calculations [74], for arbitrary values of L and $_{P}$,

$$r(k) = rk$$
 for $k = \frac{2}{P}; \frac{1}{L}$ (34)

The dimensionless parameter $_{\rm r}$ =L depends on 2 L= $_{\rm P}$ only, and its expression is given by equation (8) in [74]. In Fig. 9, we plot the coe cient $_{\rm r}$ as a function of L with $_{\rm P}$ = 137nm. In the limit of short distances, we recover the expression which was drawn in [71] from older calculations [64] (after a correction by a global factor 2)

$$_{\rm r} = 0.4492 {\rm L}$$
 for k⁻¹ L $\frac{{\rm P}}{2}$ (35)



FIG.8: Variation of r versus k for L = 50, 100, 200, 400 nm (from bottom to top curve).



FIG. 9: Variation of the coe cient $_{\rm r}$ versus L. The analytical result for k 1 L $_{\rm P}$ is shown as the dotted line and for k 1 $_{\rm P}$ L as the dashed line. A comparison between this second result (dashed straight line) and the exact $_{\rm r}$ (k) (solid line) is shown in the inlet for L = 2 m. The analytical result $_{\rm r}$ = Lk=3 predicted by the model of perfect re ectors (dotted line) is valid only in the interm ediate range $_{\rm P}$ k 1 L.

In the opposite lim it of large distances, the coe cient r_{1} is found to saturate [74]

$$_{r} = \frac{14}{152} \frac{P}{2}$$
 for $k^{1} \frac{P}{2}$ L (36)

It is interesting to note that this result di ers from the long distance behavior which was drawn in [71] from the reanalysis of calculations of the e ect of sinusoidal cornugations on perfectly re ecting plates [66]. Perfect reectors indeed correspond to the limiting case where $_{\rm P}$ rather than 1=k is the shortest length scale. The following result is obtained in this case [74], which e ectively ts that of [66],

$$_{r} = \frac{1}{3}Lk$$
 for $_{P}$ k^{1} L (37)

The long-distance behavior is thus given by (36) when 1=k $_{\rm P}$ L but by (37) when $_{\rm P}$ 1=k L. The cross-over between these two regimes is shown in the inlet of Fig. 9, where we plot $_{\rm r}$ as a function of k for L = 2 m. The failure of the perfect re ection m odel for 1=k $_{\rm P}$ has been given an interpretation in [74]: it results from the fact that not only the incoming eld m ode but also the outgoing one have to see the m irror as perfectly re ecting for form ula (37) to be valid.

These num erical results can be used to assess the accuracy of the PFA applied to the problem of roughness. PFA is indeed recovered at the lim it of very smooth surface proles and the deviation from PFA given by our results as soon as the roughness wavevector goes out of this lim it. Them informs used in a given experiment have a specie croughness spectrum which can, and in our opinion must be, measured when the experiments are performed. The integral (30) then leads to a reliable prediction for the roughness correction, as soon as the spectral sensitivity $G_r(k)$ and the real spectrum (k) are inserted into it.

B. LateralCasim ir force com ponent

The spectral sensitivity G_r(k) involved in the calculation of the roughness correction can be considered as a further prediction of Q uantum E lectroD ynam ics, besides the more commonly studied mean Casim ir force, so that the com parison of its theoretical expectation with experiments is an interesting prospect. But this comparison can hardly rely on the roughness correction (30) which remains in any case a small variation of the longitudinal Casim ir e ect. A more stringent test can be perform ed by studying the lateral component of the Casim ir force which arises between corrugated surfaces. This lateral Casim ir force would indeed vanish in the absence of surface corrugation so that the expression of the spectral sensitivity will thus appear directly as a factor in front of the lateralCasim ir force. For reasons which will become clear below, the spectral sensitivity involved in the calculation of corrugation e ect is a di erent function $G_{c}(k)$.

Nice experiments have shown the lateral Casimir force to be measurable at separations of a few hundred nanom eters [61], that is of the same order of magnitude as the plasm a wavelength $_{\rm P}$. It follows that these experiments can neither be analyzed by assuming the mirrors to be perfect re ectors [67], nor by using the opposite limit of plasm on interaction [64]. It is no more possible



FIG.10: Surface pro les considered for the lateral component of the C asim ir force. Both surfaces have a sinusoidal corrugation with a_1 and a_2 being the corrugation am plitudes, b the m ism atch between the two sinusoidal functions.

to use the PFA if we want to be able to treat arbitrary values of the ratio of the corrugation wavelength $_{\rm C}$ to the interplate distance L. This is why we emphasize the results drawn from the non-specular scattering formula (28) which can be used for calculating the lateralC asim ir force for arbitrary relative values of $_{\rm P}$, $_{\rm C}$ and L. The only drawback of this calculation is that it is restricted to sm all enough corrugation amplitudes, since the latter have to remain the sm allest length scale for perturbation theory to hold. But the lateral force is known to be experimentally accessible in this regime. Again we model the optical response of the metallic plates by the plasm a model.

The surface proles of the corrugated plates are dened by two functions $h_i(r)$, with r = (x;y) is the lateral position along the surfaces of the plates while i = 1;2 labels the two plates. As in experiments [61], we consider the simple case of uniaxial sinusoidal corrugations imprinted on the two plates (see Fig.10) along the same direction, say the y direction, and with the sam ewavevector k = 2 = c

$$h_1 = a_1 \cos(kx)$$
; $h_2 = a_2 \cos(k(x + b))$ (38)

Both pro les h_1 and h_2 have zero spatial averages and they are counted as positive when they correspond to local length decreases below the mean value L.

For the purpose of the calculation of the lateral Casim ir force, the non-specular relection matrix R i have to be developed up to the storder in the deviations hit from atness of the two plates. They are thus written as the sum of a zero-th order contribution identifying to the specular relection amplitude and of a rst-order contribution proportional to the Fourier component at wavevector (k k⁰) of the surface pro les, this Fourier component being able to induce a scattering of the eld modes from the wavevector k to $k^0\,$ [76]. The correction of the Casim ir energy E_{PP} induced by the corrugations arises at second order in the corrugations, with crossed terms of the form $a_1 a_2$ which have the ability to induce lateral forces. In other words, the corrugation sensitivity function G_c(k) obtained below depends on the crossed correlation between the pro les of the two plates, in contrast to the function G_r(k) calculated above for describing the roughness spectral sensitivity. The latter were depending on term s quadratic in h_1 or h_2 ; and

The result of the calculation is read as a second-order correction induced by corrugations

$$E_{PP} = 2 \frac{d^2k}{(2)^2A} G_c(k) H_1(k) H_2(k)$$
(39)

with the function $G_c(k)$ given by equation (3) in [76]. For isotropic media, symmetry requires $G_c(k)$ to depend only on the modulus of the wavevector $k = \frac{1}{2}$, $W \in m$ ay also assume for simplicity that the two plates are made of the same metallic medium. The energy correction thus depends on the lateral mism atch b between the corrugations of the two plates, which is the cause for the lateral force to arise. Replacing the ill-de ned (2)² (2) (0) by the area A of the plates, we derive from (39)

$$E_{PP} = a_1 a_2 \cos(kb) G_c(k)$$
 (40)

O noe again, the result of the PFA is recovered from equation (40) as the limiting case k ! 0, that is also for long corrugation wavelengths. This corresponds to nearly plane surfaces where the C asim ir energy can be obtained from the energy E_{PP} calculated between perfectly plane plates by averaging the 'local' distance $L = L - h_l - h_l$ over the surface of the plates. Expanding at second order in the corrugation am plitudes and disregarding squared terms in a_1^2 and a_2^2 because they cannot produce a lateral dependence, we thus recover expression (40) with G $_c$ (k) replaced, for sm all values of k or equivalently large values of $_c$, by G $_c$ (0) given by (com pare with (31))

$$G_{c}(k ! 0) = \frac{E_{PP}^{0}}{2}$$
 (41)

This property is ensured, for any speci c model of the material medium, by the fact that G_c is given by the specular lim it of non specular relation amplitudes [76] for k ! 0. For arbitrary values of k, the deviation from PFA is then described by the ratio

$$_{c}(k) = \frac{G_{c}(k)}{G_{c}(0)}$$
 (42)

In the following, we discuss explicit expressions of this ratio $_{\rm c}$ given by its general expression (eq. (3) in [76]). For the num erical examples, we take $_{\rm P}$ = 137nm, corresponding to gold covered plates. The result $_{\rm c}$ is plotted on Fig. 11 as a function of k, for di erent values of the distance L.

For example for a distance L = 50nm, the Proximity Force Approximation is correct in the range k 0.01nm⁻¹ (i.e. _c 628nm) covered by the plot in Fig. 11. However, for typical separations of 100nm or larger, _c drops signicantly below its PFA value of unity. A more detailed discussion can be found in [76].

For still larger values of kL, the functions $G_{c}(k)$ and c(k) decay exponentially to zero. If we also assume that



FIG.11: Variation of $_{\rm c}$ versus k with $_{\rm P}$ = 137nm and for L = 50nm (dotted line), 100nm (dash-dotted line), 200nm (solid line) and 400nm (dashed line).



FIG.12: Lateral force amplitude for the plane-sphere setup, as a function of k; with gures taken from [61]. The experimental value k = 0.0052 nm⁻¹ is indicated by the vertical dashed line.

 k_{P} 1, we nd $G_{c}(k) = {}_{c}k \exp(kL)$ where the parameter ${}_{c}$ now depends on ${}_{P}$ and L only. This is in striking contrast with the behavior of the response function for stochastic roughness, which grows linearly with k for large k due to the contribution of the secondorder re ection coe cients [75]. These coe cients do not contribute to the second-order lateral e ect, which is related to two rst-order non-specular re ections at di erent plates, separated by a one-way propagation with a m odi ed m om entum of the order of k. The resulting propagation factor is, in the large-k lim it, exp(L) exp(kL), thus explaining the exponential behavior.

C. Comparison to experiments in a plane-sphere

In order to compare the theoretical expression of the lateral C asim ir force to experiments, we have to consider the plane-sphere (PS) geometry [61] rather than the plane-plane (PP) one. As R L, we use the PFA to connect the two geometries. Any interplay between curvature and corrugation is avoided provided that RL $\frac{2}{c}$. These two conditions are met in the experiment reported in [61], where R = 100 m, $_{c}$ = 12 m and L 200nm.

con guration

We thus obtain the energy correction E_{PS} between the sphere and a plane at a distance of closest approach L as an integral of the energy correction E_{PP} in the PP geometry

$$E_{PS} (L;b) = \int_{1}^{Z} \frac{2 R dL^{0}}{A} E_{PP} (L^{0};b)$$
(43)

Then the lateral force is deduced by varying the energy correction (43) with respect to the lateralm ism atch bbetween the two corrugations. Sim ple manipulations then lead to the lateralCasim ir force in the PS geometry

$$F_{PS}^{lat} = \frac{2 a_1 a_2}{A} kR \sin (kb) \int_{1}^{Z} dL^0 G_c (k; L^0)$$
(44)

The force attains a maxim alam plitude for sin (kb) = 1, which is easily evaluated in the PFA regime k ! 0 where G_{c} (k) does not depend on k, so that F_{PS}^{lat} scales as k: A s k increases, the amplitude increases at a slower rate and then starts to decrease due to the exponential decay of $G_{c}(k)$. For a given value of the separation L, the lateral force reaches an optimum for a corrugation wavelength such that kL is of order of unity, which generalizes the result obtained for perfect re ectors in [66]. In Fig. 12, we plot the force F_{PS}^{lat} (for sin (kb) = 1) as a function of k, with gures taken from the experiment of Ref. [61]. W e also use the values $a_1 = 59$ nm and $a_2 = 8$ nm of the amplitudes for measuring the force as in [61], reminding how ever that our calculations are valid in the perturbative $\lim it a_1; a_2 ! 0$.

The plot clearly shows the linear growth for small k as well as the exponential decay for large k. The maximum force is at k = 0.009 nm⁻¹ so that kL ' 2. The experimental value k = 0.0052 nm⁻¹ is indicated by the dashed line in Fig.12, and the force obtained as 0.20pN, well below the PFA result, indicated by the straight line and corresponding to a force of 0.28pN.

Such a variation in the lateralCasim ir force should in principle be measurable in an experiment. This could lead to the rst unam biguous evidence of the limited validity of the Proximity Force Approximation, that is also to the rst observation of a non trivial e ect of geometry on the Casim ir force.

IV. CONCLUSION

In this review we have described the theory of the C asim ir e ect using the techniques of scattering theory. We have recalled how this form alism allows ones to take into account the real conditions under which C asim ir force m easurem ents are perform ed.

In particular, the nite conductivity e ect can be treated in a very precise manner, which is a necessity for a reliable theory-experiment comparison. There however remain inaccuracies in this comparison if the reaction amplitudes are drawn from optical models, because of the intrinsic dispersion of optical properties of samples fabricated by dierent techniques. We have emphasized that these inaccuracies could be circum vented by measuring these reaction amplitudes rather than modeling them.

We have then presented the scattering formulation of the Casim ir force at non zero temperature. This form ulation clears out the doubt on the expression of the force while again requiring to have at one's disposal relection amplitudes representing the real properties of the mirrors used in the experiments. Let us at this point emphasize that the elect of temperature has not been unambiguously proven in experiments, and that its observation is one of the most urgent challenges of experimental research in the domain. An interesting possibility would be to perform accurate m easurem ents of the force at distances larger than a few m icrons, for example by using torsional balances [98].

In the second part of the paper, we have presented a more general scattering form alism which takes into account non-specular rejection. We have also discussed the application of this form alism for the calculation of the roughness correction to the longitudinal C asim ir force as well as of the lateral component of the C asim ir force arising between corrugated surfaces. We have argued that the spectral sensitivity functions appearing in these expressions have to be considered as a new prediction of Q uantum ElectroD ynamics, which dier from the more commonly studied mean C asim ir force as soon as one goes out of the dom ain of validity of the PFA. This new test seems to be experimentally feasible and constitutes another challenge of great interest to be faced in the near future.

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